## Application/Control No. Applicant(s)/Patent Under Reexamination 09/753,187 LEE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 DANG T. TON 2666 **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY 10-2001 370/252 US-6,307,840 B1 Wheatley et al. Α 06-2001 370/333 US-6,246,673 B1 Tiedemann et al. В US-С D US-US-Ε F US-US-G US-Н US-US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν O Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ν W

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